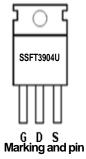


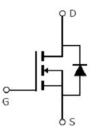
Main Product Characteristics:

| V _{DSS} | 35V |
|----------------------|---------------|
| R _{DS} (on) | 3.0mohm(typ.) |
| I _D | 110A |





Assignment



Schematic diagram

TO220

Features and Benefits:

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature



Description:

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

Absolute max Rating:

| Symbol | Parameter | Max. | Units |
|---|--|--------------|-------|
| I _D @ TC = 25°C | Continuous Drain Current, V _{GS} @ 10V① | 110 | |
| I _D @ TC = 100°C | Continuous Drain Current, V _{GS} @ 10V① | 80 | Α |
| I _{DM} | Pulsed Drain Current② | 440 | |
| D @TC 25°C | Power Dissipation③ | 100 | W |
| P _D @TC = 25°C | Linear Derating Factor | 0.55 | W/°C |
| V _{DS} | Drain-Source Voltage | 35 | V |
| V_{GS} | Gate-to-Source Voltage | | V |
| E _{AS} Single Pulse Avalanche Energy @ L=0.1mH | | 320 | mJ |
| I _{AS} | Avalanche Current @ L=0.1mH | 80 | Α |
| T _J T _{STG} | Operating Junction and Storage Temperature Range | -55 to + 175 | °C |



Thermal Resistance

| Symbol | Characterizes | Тур. | Max. | Units |
|-------------------|---|------|------|-------|
| $R_{\theta JC}$ | Junction-to-case③ | _ | 1.5 | °C/W |
| Б | Junction-to-ambient (t \leq 10s) (4) | _ | 62 | °C/W |
| R ₀ JA | Junction-to-Ambient (PCB mounted, steady-state) ④ | _ | 40 | °C/W |

Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

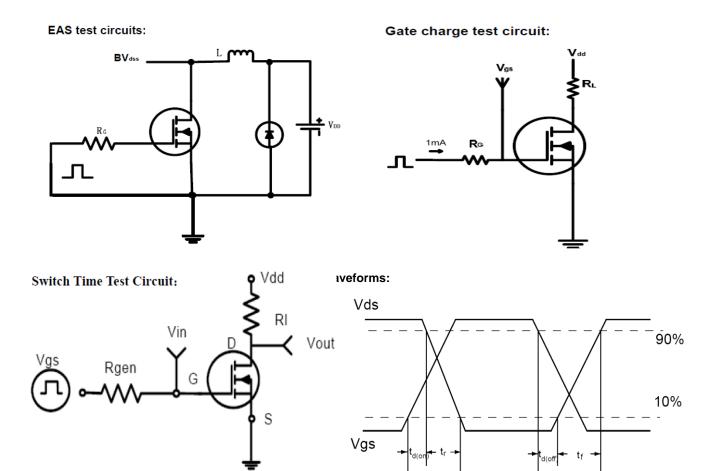
| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions | |
|----------------------|--|------|-------|------|-------|---|--|
| V _{(BR)DSS} | Drain-to-Source breakdown voltage | 35 | _ | _ | V | V _{GS} = 0V, ID = 250μA | |
| D | Otatia Dania ta Ocuma an maiatana | _ | 3 | 4 | mΩ | V _{GS} =10V,I _D =30A | |
| $R_{DS(on)}$ | Static Drain-to-Source on-resistance | _ | 3.9 | _ | 11152 | T _J = 125℃ | |
| Pro/ | Static Drain-to-Source on-resistance | _ | 5 | 6 | mΩ | V _{GS} =4.5V,I _D =16A | |
| R _{DS(on)} | Static Dialif-to-Source off-resistance | _ | 5.8 | _ | | T _J = 125℃ | |
| $V_{GS(th)}$ | Gate threshold voltage | 1 | _ | 3 | V | $V_{DS} = V_{GS}, I_D = 250\mu A$ | |
| V GS(th) | Gate tilleshold voltage | _ | 1.1 | _ | V | T _J = 125℃ | |
| l | Drain-to-Source leakage current | _ | _ | 1 | μA | $V_{DS} = 35V, V_{GS} = 0V$ | |
| I _{DSS} | Diam-to-Source leakage current | _ | _ | 50 | μΑ | T _J = 125°C | |
| Lana | Gate-to-Source forward leakage | _ | _ | 100 | nA | V _{GS} =20V | |
| I _{GSS} | | -100 | _ | _ | | V _{GS} = -20V | |
| Q_g | Total gate charge | _ | 57 | _ | | V _{DS} =15V, | |
| Q_{gs} | Gate-to-Source charge | _ | 17 | _ | nC | I _D =30A, | |
| Q_{gd} | Gate-to-Drain("Miller") charge | _ | 26 | _ | | V _{GS} =10V | |
| t _{d(on)} | Turn-on delay time | _ | 14.5 | _ | | | |
| t _r | Rise time | _ | 73.9 | _ | ns | V _{GS} =4.5V, VDS=15V, | |
| t _{d(off)} | Turn-Off delay time | _ | 99.7 | _ | | R_{GEN} =4.7 Ω , I_D =30A | |
| t _f | Fall time | | 107.1 | _ | _ | | |
| C _{iss} | Input capacitance | | 5520 | _ | | V _{GS} = 0V | |
| Coss | Output capacitance | _ | 623 | _ | pF | V _{DS} = 15V | |
| C _{rss} | Reverse transfer capacitance | _ | 594 | _ | | f = 600KHz | |

Source-Drain Ratings and Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|------------------------------|---------------------------|------|------|------|-------|---|
| | Continuous Source Current | | _ | 110 | А | MOSFET symb |
| I _S | (Body Diode) | _ | | | | showing the (|
| I _{SM} | Pulsed Source Current | | _ | 440 | А | integral reverse |
| | (Body Diode) | _ | | | | p-n junction diode. |
| $V_{\scriptscriptstyle{SD}}$ | Diode Forward Voltage | _ | 0.67 | 1.3 | V | I _S =2.1A, V _{GS} =0V |
| t _{rr} | Reverse Recovery Time | _ | 22.1 | _ | ns | $T_J = 25^{\circ}C$, $I_F = 30A$, $di/dt =$ |
| Q _{rr} | Reverse Recovery Charge | _ | 8.7 | _ | nC | 100A/µs |



Test circuits and Waveforms

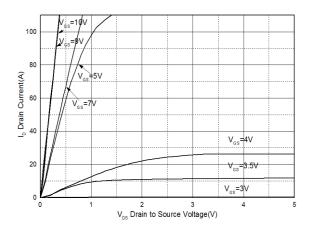


Notes:

- ①The maximum current rating is limited by bond-wires.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C
- ⑤These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=175$ °C.



Typical electrical characteristics



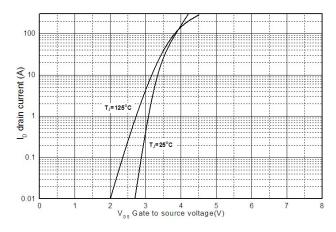


Figure 1: Typical Output Characteristics

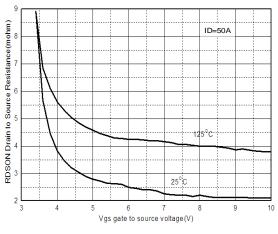


Figure 2: Typical Transfer Characteristics

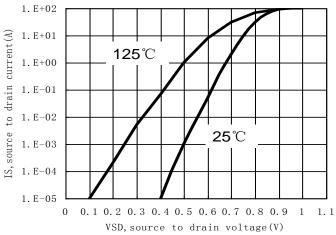


Figure 3: On-Resistance vs. Gate-Source Voltage

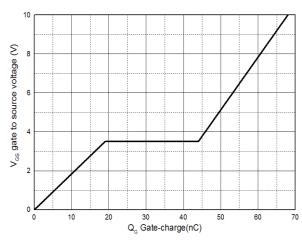


Figure 4: Body-Diode Characteristics

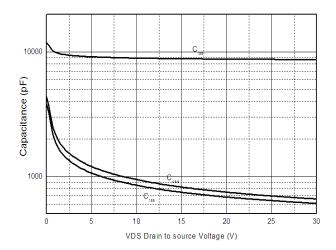


Figure 5: Gate-Charge Characteristics

Figure 6: Capacitance Characteristics



Typical thermal characteristics

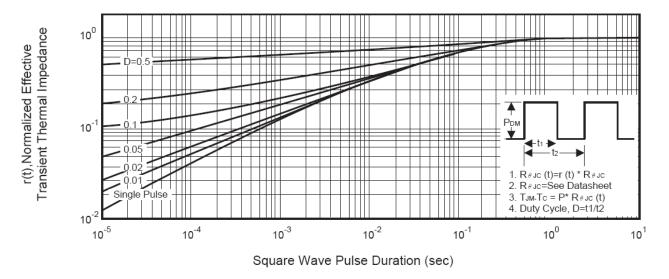
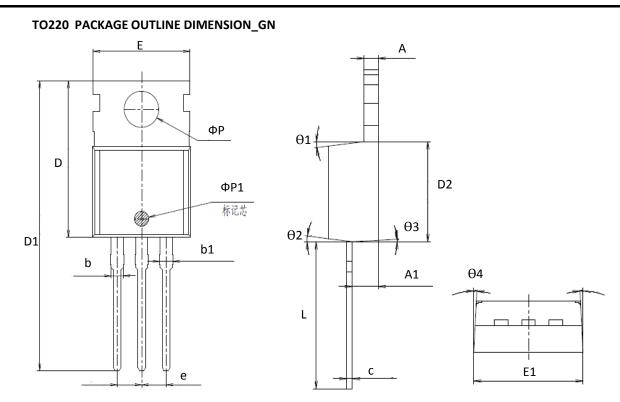


Figure 7: Normalized Thermal transient Impedance Curve



Mechanical Data:



| Symbol | Dime | nsion In Millin | neters | Dimension In Inches | | | |
|--------|--------|-----------------------|--------|---------------------|----------------|----------------|--|
| Symbol | Min | Nom | Max | Min | Nom | Max | |
| Α | - | 1.300 | - | - | 0.051 | - | |
| A1 | 2.200 | 2.400 | 2.600 | 0.087 | 0.094 | 0.102 | |
| b | - | 1.270 | - | - | 0.050 | - | |
| b1 | 1.270 | 1.370 | 1.470 | 0.050 | 0.054 | 0.058 | |
| С | - | 0.500 | - | - | 0.020 | - | |
| D | - | 15.600 | - | - | 0.614 | - | |
| D1 | - | 28.700 | - | - | 1.130 | - | |
| D2 | - | 9.150 | - | - | 0.360 | - | |
| Е | 9.900 | 10.000 | 10.100 | 0.390 | 0.394 | 0.398 | |
| E1 | - | 10.160 | - | - | 0.400 | - | |
| ΦР | - | 3.600 | - | - | 0.142 | - | |
| ФР1 | | 1.500 | | 0.059 | | | |
| е | | 2.54BSC | | | 0.1BSC | | |
| L | 12.900 | 13.100 | 13.300 | 0.508 | 0.516 | 0.524 | |
| Θ1 | - | 7 ⁰ | - | - | 7 ⁰ | - | |
| Θ2 | - | 7 ⁰ | - | - | 7 ⁰ | - | |
| Θ3 | - | 3 ⁰ | - | 5 ⁰ | 7 ⁰ | 90 | |
| Θ4 | - | 3 ⁰ | - | 1 ⁰ | 3 ⁰ | 5 ⁰ | |



Ordering and Marking Information

Device Marking: SSFT3904U

Package (Available)
TO220
Operating Temperature Range
C: -55 to 175 °C

Devices per Unit

| Package | Units/ | Tubes/Inner | Units/Inner | Inner Boxes/Carton Box | Units/Carton |
|---------|--------|-------------|-------------|------------------------|--------------|
| Type | Tube | Box | Box | | Box |
| TO220 | 50 | 20 | 1000 | 6 | 6000 |

Reliability Test Program

| Test Item | Conditions | Duration | Sample Size |
|-------------|--|------------|---------------------|
| High | T _j =125℃ to 175℃ @ | 168 hours | 3 lots x 77 devices |
| Temperature | 80% of Max | 500 hours | |
| Reverse | V _{DSS} /V _{CES} /VR | 1000 hours | |
| Bias(HTRB) | | | |
| High | T _J =125℃ to 175℃ @ | 168 hours | 3 lots x 77 devices |
| Temperature | 100% of Max V _{GSS} | 500 hours | |
| Gate | | 1000 hours | |
| Bias(HTGB) | | | |



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